

Journal of Fluorine Chemistry 110 (2001) 139-143



www.elsevier.com/locate/jfluchem

A new variety of PdF₂ synthesised by low-temperature reaction in anhydrous HF

Z. Mazej^a, A. Tressaud^{b,*}, J. Darriet^b

^aDepartment of Inorganic Chemistry and Technology, Jožef Stefan Institute, Jamova 39, SI-1000 Ljubljana, Slovenia ^bICMCB-CNRS, 87, Avenue Dr. A. Schweitzer, 33608 Pessac Cedex, France

Received 22 January 2001; accepted 1 February 2001

This work is dedicated to the memory of Dr. Karel LUTAR, deceased on 2 September 2000

Abstract

A new variety of palladium difluoride has been prepared via a low temperature (LT) process in anhydrous hydrogen fluoride (aHF). Reaction between solutions of Pd(AsF₆)₂ and CsF in aHF results in the precipitation of the light-brown LT form of PdF₂. This phase crystallises in the Pa3 cubic space group with a = 532.4(1) pm and can be derived from the fluorite structure. The co-ordination of Pd is: 6F at 217.6(3) pm + 2F at 316.8(3) pm. The structural network can be described either as PdF₈ rhombohedra sharing edges — as MX₈ cubes in the fluorite — or as flattened PdF₆ octahedra sharing corners. Each F atom is common to 3 octahedra. The relationships with the fluorite and pyrite structures have been raised. LT-PdF₂ is antiferromagnetic, with a Néel temperature evaluated at around 180 K. © 2001 Elsevier Science B.V. All rights reserved.

Keywords: PdF2; Divalent palladium; Transition element difluoride; Anhydrous HF; Fluorite; Pyrite; Antiferromagnetism

1. Introduction

All MF₂ difluorides of transition elements crystallise in the rutile structure when prepared under normal pressure conditions [1,2]. This is the case for VF₂, CrF₂, MnF₂, FeF₂, CoF₂ and NiF₂ in the 3d transition element row and for PdF₂ which is the only stable difluoride among the 4d transition elements. It is also well known that CuF₂ and AgF₂ exhibit a distorted structure because of Jahn–Teller configuration of these elements in their d^9 state. In both fluorides the $(MF_6)^{4-}$ octahedra are axially elongated with a 4+2 co-ordination number. On the other hand, the structural arrangement of many other difluorides with larger M^{2+} cations is derived from the fluorite type, e.g. for M = Ca, Sr, Ba, Cd, Hg, Pb.

In the following, we describe the synthesis and magnetic properties of a new form of palladium difluoride which has been obtained via a low-temperature (LT) reaction at ambient pressure and whose structure is intermediate between the pyrite and the fluorite structural types.

2. Results and discussion

2.1. Synthesis of LT-PdF₂

The slow mixing of solutions of $Pd(AsF_6)_2$ and CsF in anhydrous hydrogen fluoride (aHF) gives light brown LT- PdF_2 , insoluble in aHF, following the reaction

$$Pd(AsF_6)_2 + 2CsF \mathop \to \limits_{\substack{298 \text{ K}}} ^{\substack{aHF}} LT\text{-}PdF_2 + 2CsAsF_6$$

Because of the higher solubility of $CsAsF_6$ in aHF thorough washing of the LT-PdF₂ precipitate with aHF allows to eliminate $CsAsF_6$. X-ray powder diffraction pattern showed no detectable lines of $CsAsF_6$. However, the presence of very small amounts of Pd and rutile-type form of PdF_2 were noticed in some cases. The presence of traces of Pd metal in the final product can be explained by an incomplete oxidation of Pd in the presence of fluorine and AsF_5 in aHF medium. Great care has to be taken while adding fluorine to the reaction mixture $Pd/AsF_5/aHF$: a slight excess of fluorine only is required to oxidise Pd into Pd^{2+} , otherwise the oxidation proceeds to Pd^{4+} with the formation of in an aHF insoluble by-product Pd_2F_6 ($Pd^{II}Pd^{IV}F_6$), which can be formed instead of the desired solution of $Pd(AsF_6)_2$ in aHF [3].

^{*}Corresponding author. Tel.: +33-5-56-846301; fax: +33-5-56-842761. E-mail address: tressaud@icmcb.u-bordeaux.fr (A. Tressaud).

It has been previously reported that clear-blue solutions of the Pd in SbF₅/aHF give a precipitate of lilac PdF₂ when treated with solutions of alkali fluoride in aHF [4]. In these conditions, the obtained PdF₂ was identified by its type X-ray powder diffraction pattern as the conventional rutile form. In our experiment the result of the mixing of solutions of Pd(AsF₆)₂ and CsF in aHF gives mainly the fluorite-derived form and only traces of the rutile form are observed. A clear explanation of the difference between the reaction of Pd(SbF₆)₂ with alkali fluoride in aHF one hand, and that of Pd(AsF₆)₂ with alkali fluoride on the other hand has not been elucidated so far.

2.2. Structural determination of LT-PdF₂

The X-ray diffraction (XRD) pattern of the LT form of PdF_2 is given in Fig. 1. All peaks can be indexed in the cubic symmetry, with an unit-cell constant of 532.4(1) pm, except four weak peaks which can be attributed to Pd metal $(2\theta = 40.22 \text{ and } 46.24^{\circ})$ and rutile PdF_2 $(2\theta = 25.41 \text{ and } 32.00^{\circ})$ (Fig. 1). The XRD pattern of LT-PdF₂ has many similarities with those of fluorite-type patterns. The systematic extinctions correspond to Pa3 space group (no. 205). It is the first time that such characteristics are observed for a transition element difluoride prepared at ambient pressure. It can be noted that similar features had been previously obtained when PdF_2 (or AgF_2 [5]) was prepared under very

high pressures [6]. Transformation from the rutile-type structure started at about 15 kbar solid state pressure and more drastic conditions were required, e.g. reactions at 673 K and 50 kbar, to get fairly crystallised high pressure (HP) form of PdF₂ [7].

The structural refinement of LT-PdF₂ has been carried out by analogy with the fluorite-type structure. Pd atoms occupy the 4a positions (0, 0, 0) and the F atoms are located in the 8c positions (x, x, x, with x = 0.3436(4)). The final R values are $R_{\rm I} = 3.34\%$, $R_{\rm p} = 7.71\%$, and $R_{\rm wp} = 12.00\%$. The isotropic displacement factors are $B = 0.75(2) \text{ Å}^2$ for Pd, and $B = 1.41(9) \text{ Å}^2$ for F atoms. The observed, calculated, and difference X-ray profiles are shown in Fig. 1. A representation of the structure is given in Fig. 2. The palladium atoms form a fcc network and are surrounded by six fluorine atoms as nearest neighbours at Pd-F = 217.6(3) (Fig. 2). In this octahedral configuration, the Pd-F distances are identical but the F–Pd–F angles differ from 90° (87.5°) leading to a flattened octahedra with two opposite faces much larger than the three other pairs. Two further fluorine atoms at Pd-F = 316.8(3) pm are located on each side of these larger triangular faces. The total co-ordination number of Pd is 6+2 and can be represented either as a regular rhombohedron or as a bicapped flattened octahedron (Fig. 3).

The structural network can be therefore described either as formed of edge-shared PdF₈ rhombohedra, as MX₈ cubes in the fluorite (see Fig. 3), or of distorted corner-shared

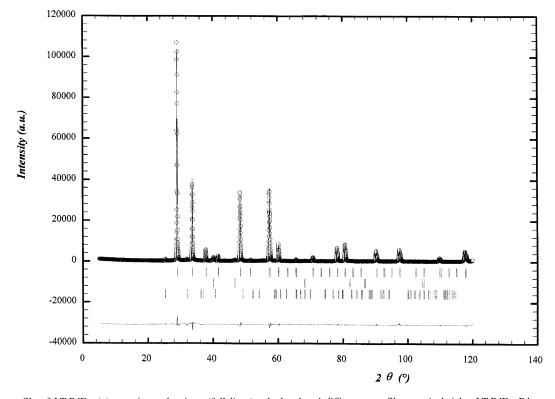


Fig. 1. X-ray profile of LT-PdF₂: (o) experimental points; (full lines) calculated and difference profiles; vertical ticks: LT-PdF₂, Pd metal, rutile-PdF₂, successively.

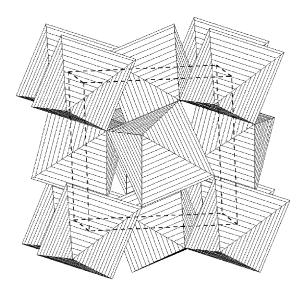


Fig. 2. Network of PdF₆ distorted octahedra in the structure of LT-PdF₂.

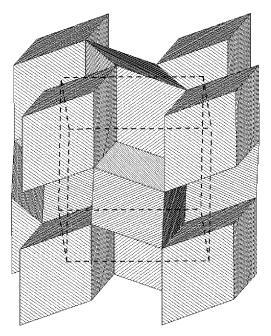


Fig. 3. Network of PdF₈ rhombohedra in LT-PdF₂.

octahedra. In this latter presentation, each fluorine atom would be shared by three octahedra, as shown in Fig. 2. The structure is thus intermediate between the fluorite type and the pyrite type. The anionic positions (8c sites) are indeed

Table 1 Environment of M2+ cations in various MX2 structures

1500 F		T		-				
γ-/(emu/mol) -1 1000	-	00000000	xxxxxxxxxxx)000 ₀₀ 0000	°000000000000000000000000000000000000	900000000	- 	
500	θ,	= - 548	3 K					
0	0	50	100	150	200	250	300	
						T (K	2)	
Temperat	ture c	lepend	ence of	the rec	iprocal	magnet	ic susce	pt

Fig. 4. tibility of LT-F

intermediate with x = 0.25 in the fluorite, x = 0.3436 in LT-PdF₂, x = 0.39 in pyrite-type FeS₂.

Both LT-PdF₂ and pyrite compounds crystallise in the same Pa3 space group with similar unit-cell constants. It is clear however that in the case of LT-PdF₂ no F-F pairs are found as for S-S pairs in the pyrite, and F-F distances between two octahedra exhibit usual bond lengths, i.e. ≈280 pm. Environments of M cations in various MX₂ structures are compared in Table 1.

2.3. Magnetic properties

The temperature dependence of the reciprocal susceptibility is shown in Fig. 4 for a LT-PdF₂ sample which could be obtained free of rutile-type impurity in very small amount. The general shape is consistent with an antiferromagnetic behaviour. A linear magnetic field dependence of the magnetisation is observed down to 4.2 K. No parasitic ferromagnetic component occurs, in contrast to that observed in the case of rutile PdF₂ [8]. The temperature corresponding to the minimum of reciprocal susceptibility is around 180 K, a value which is similar to the Néel temperature of HP-PdF₂ ($T_N = 190 \text{ K}$) determined from neutron diffraction data [7]. The Curie constant $C_{\text{mol}} = 1$ can be deduced from the value of the paramagnetic Curie temperature: $\theta_p = -548$ K, and that of room temperature reciprocal susceptibility: $\chi_{M}^{-1}=848$ emu at 300 K. This value is consistent with the S = 2/2 electronic configuration (spin-only) of high-spin Pd(+II).

Compound	Coordination number of M ²⁺ cation	Closest X–X distance (pm) 150 (O–O pairs)	
β-HgO ₂	2 + 4: compressed octahedra		
PdS_2	4 + 2: elongated octahedra	213 (S–S pairs)	
FeS ₂ (pyrite)	6: regular octahedra	217 (S–S pairs)	
AgF_2	4+2: elongated octahedra	286 [12]	
PdF ₂ (rutile)	6: regular octahedra	272 [13]	
LT-PdF ₂	6 + 2: bicapped flattened octahedra	284ª	

^a This work.

3. Concluding remarks

In the transition-metal difluorides, the sequence of compactness is the following for a same cation: fluorite > LT-PdF₂ > rutile, and may explain why the obtained form is stabilised with respect to the rutile form via a LT process. It has been proposed that under high pressure conditions rutile-type fluorides reversibly transform into this structure in a first step and then into fluorite or α -PbCl₂ structures [9]. It can be considered that this peculiar structural type appears only for divalent cations with anion radii intermediate between those of d transition elements and of bigger alkaline earth elements: Cd_{0.5}Pd_{0.5}F₂, Mg_{0.5}Pd_{0.5}F₂, high pressure forms of PdF₂ and AgF₂ [2].

4. Experimental

4.1. Materials

Volatile materials (AsF₅, aHF) were manipulated in an all-Teflon vacuum line equipped with Teflon valves. The manipulation of the non-volatile materials was done in a dry-box (M. Braun). The residual water in the atmosphere of the dry-box never exceeded 1 ppm. The synthesis of LT-PdF₂ was carried out in a T-shape FEP reaction vessel (i.d. 15.5 mm, o.d. 18.75 mm) equipped with two Teflon valves and Teflon coated stirring bars. An additional Teflon valve separated both arms of the T-shape reaction vessel. Prior to use, the reaction vessel was passivated with elemental fluorine.

CsF (Ventron, 99.9%) and Pd (Alfa Products, 99.9%) were used as supplied. Purity of CsF was checked by chemical analysis (obtained %F, 12.4; calculated %F, 12.51). AsF₅ was synthesised by pressure fluorination of arsenic trioxide with elemental fluorine in a nickel reactor at 573 K as previously described for the synthesis of PF₅ [10]. Fluorine was used as supplied (Solvay, 99.98%). Anhydrous HF (Praxair, 99.9%) was treated with K_2NiF_6 for several hours prior to use.

4.2. Reaction process

Synthesis of LT-PdF₂ was done several times in the same manner. Only one typical procedure is described. An amount of 0.261 g (2.45 mmol) of Pd was loaded in the dry-box into one arm and 1.100 g (7.24 mmol) of CsF into the other arm of a T-shape FEP reaction vessel equipped with two Teflon valves. aHF (10 ml) was then condensed onto CsF from a FEP reservoir containing K₂NiF₆. The Teflon valve separating both arms of reaction vessel was closed and 10 ml of aHF with 1.190 g (7.00 mmol) of AsF₅ were added onto Pd, both at 77 K. The reaction vessel was warmed up to 298 K and a approx. 2.60 mmol of fluorine was slowly added into the arm containing Pd, AsF₅ and aHF. Pd metal otherwise insoluble in aHF, slowly dissolved due to the presence of AsF₅. The reaction was carried out at room temperature until a clear green-blue solution of Pd(AsF₆)₂ [3] in aHF was obtained. The reaction vessel was cooled down on 77 K and volatile

components were pumped away. After warming the reaction vessel up to 298 K, the Teflon valve separating both tubes of the T-shape reaction vessel was opened and the solution of $Pd(AsF_6)_2$ in aHF was slowly added in small batches to the solution of CsF in aHF. A dark solid immediately precipitated, which slowly changed to a light brown product. After 1 h of intensive stirring, the solution of CsAsF₆ in aHF was decanted away from the precipitate and aHF was condensed back onto the light brown solid at 77 K. After warming the reaction vessel to room temperature and 10 min of intensive stirring, the liquid phase was decanted again. This operation was repeated 25 times to eliminate CsAsF₆ from the light brown solid. Finally, volatile materials were pumped away at room temperature and the light brown material was recovered in one arm of the T-shape reaction vessel. The X-ray diffraction pattern of the light brown product showed that most lines corresponded to an original pattern having a cubic cell deriving from the fluorite type. Very weak lines of Pd metal and rutile-type form of PdF2 were also identified in some cases.

The X-ray diffraction powder pattern of the brownish material isolated from the decanted solution gave only the pattern of CsAsF₆; the colour indicated however the presence of a small amount of PdF₂.

4.3. X-ray diffraction (XRD) analysis

The XRD analysis was performed on powder samples using the Bragg–Brentano technique. Cu $K\alpha$ radiation was diffracted through a beam graphite monochromator with scan up to 120° with steps of 0.02° (2θ). Because of its high reactivity to moisture, the sample was set in an air-tight cell with Teflon O-rings and a mylar window. The powder was deposited onto the holder of the cell inside the glove box. Rietveld refinement of the XRD pattern was carried out using the FULLPROF program [11], and the pseudo-Voigt function $PV = \eta L + (1 - \eta)G$ for diffraction line profile.

4.4. Magnetic measurements

Cylindrical screw-capped sample containers ($V \approx 0.5$ ml, $m \approx 0.250$ mg) for magnetic measurements of PdF₂ were made of Kel-F (polytrifluorochloroethylene) and were additionally tightened with Teflon gaskets. Prior to their use, both the container and Kel-F packing tool were passivated with elemental fluorine. The field dependence of the magnetisation was measured between 0 and 5 T for various temperatures in the 4.2–300 K range using a SQUID magnetometer (MPMS-5S, Quantum Design).

Acknowledgements

The authors acknowledge the financial support of the French-Slovenian scientific cooperation programme PROTEUS.

References

- A.F. Wells, Structural Inorganic Chemistry, Oxford University Press, Oxford, 1991, pp. 247 and following.
- [2] D. Babel, A. Tressaud, Crystal chemistry of fluorides, in: P. Hagenmuller (Ed.), Inorganic Solid Fluorides, Academic Press, New York, 1985, pp. 77–203.
- [3] Z. Mazej, K. Lutar, B. Žemva, J. Darriet, J. Grannec, A. Tressaud, in: Proceedings of the 12th European Symposium on Fluorine Chemistry, Berlin, 1998, Abstract B20.
- [4] G. Lucier, S.H. Elder, L. Chacón, N. Bartlett, Eur. J. Solid State Inorg. Chem. 33 (1996) 809–820.
- [5] B.G. Müller, Naturwiss. 66 (1979) 519-520.

- [6] A. Tressaud, F. Langlais, G. Demazeau, P. Hagenmuller, Mat. Res. Bull. 14 (1979) 1147–1153.
- [7] A. Tressaud, J.L. Soubeyroux, H. Touhara, G. Demazeau, F. Langlais, Mat. Res. Bull. 16 (1981) 207–214.
- [8] P.R. Rao, R.C. Sherwood, N. Bartlett, J. Chem. Phys. 49 (1968) 3729–3730.
- [9] A. Tressaud, G. Demazeau, High Temp. High Press. 16 (1984) 303–308.
- [10] A. Jesih, B. Žemva, Vestn. Slov. Kem. Drus. 33 (1986) 25–28.
- [11] J. Rodriguez-Carvajal, in: Collected Abstr. Powder Diffr. Meeting, Toulouse, 1990, p. 127.
- [12] A. Jesih, K. Lutar, B. Žemva, B. Bachmann, S. Becker, B.G. Müller, R. Hoppe, Z. Anorg. Allgem. Chem. 588 (1990) 77–83.
- [13] B. Bachmann, B.G. Müller, Z. Anorg. Allgem. Chem. 619 (1993) 387–393.